


<b>Search Notes</b>  	<b>Application/Control No.</b>  10562279	<b>Applicant(s)/Patent Under Reexamination</b>  KOYAMA ET AL.
	<b>Examiner</b>  K. Richard Lee	<b>Art Unit</b>  2832

SEARCHED			
Class	Subclass	Date	Examiner
338	22R, 49, 260, 295, 312, 317, 320	3/15/08	/KL/

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner